

University of Toronto
Faculty of Applied Science and Engineering

Final Examination

Date - Monday, April 23rd, 2001

Duration: 2 hours 30 mins.

ECE530S — Analog Electronics

Examiner - K. Phang

ANSWER QUESTIONS ON THESE SHEETS USING BACKS IF NECESSARY

1. Two, double-sided aid-sheets are allowed.
2. Grading is indicated by []. Attempt all questions since a blank answer will certainly get 0.
3. Unless otherwise stated, use the device equations and parameter values found at the back of this exam paper.

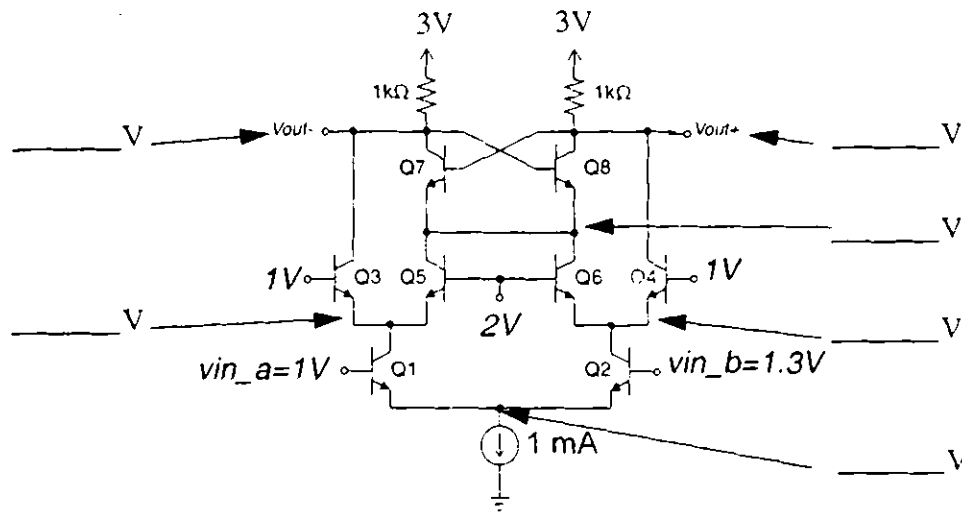
Last Name: _____

First Name: _____

Student #: _____

Question	Mark
1	/8
2	/10
3	/10
4	/6
5	/8
6	/8
Total	/50

Question 1: [8] For the latched comparator circuit shown below



a) Circle what mode the latched comparator is currently in.

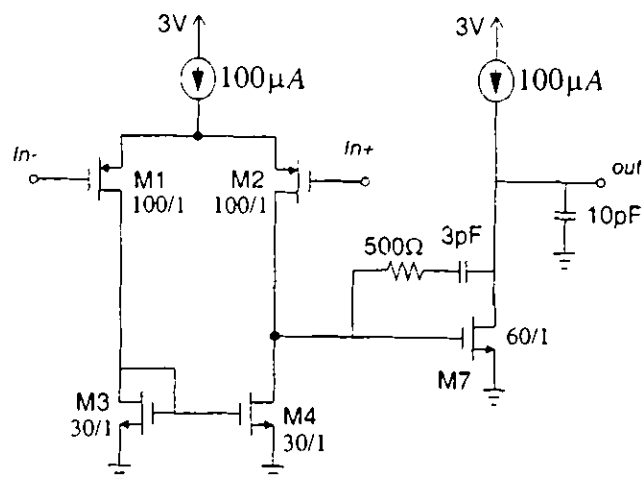
Latched Tracking

b) Assuming the input voltages are fixed, circle below the devices that are currently OFF.

Q1 Q2 Q3 Q4 Q5 Q6 Q7 Q8

c) Determine the SIX marked node voltages, assuming that $V_{BE} = 0.7V$ when a bipolar transistor is on and that $V_{CE} = 0.2V$ when the transistor is saturated.

Question 2: [10] For the following op amp circuit, assume $r_{ds} = 100k\Omega/\mu m \times L(\mu m)$, but otherwise use the process parameters for the 0.5 μm process found on equation summary sheet. Device W/L ratios are given in the diagram beside each device.



- a) Give the expression for the small-signal gain, and calculate its value. Assume all current sources are ideal.

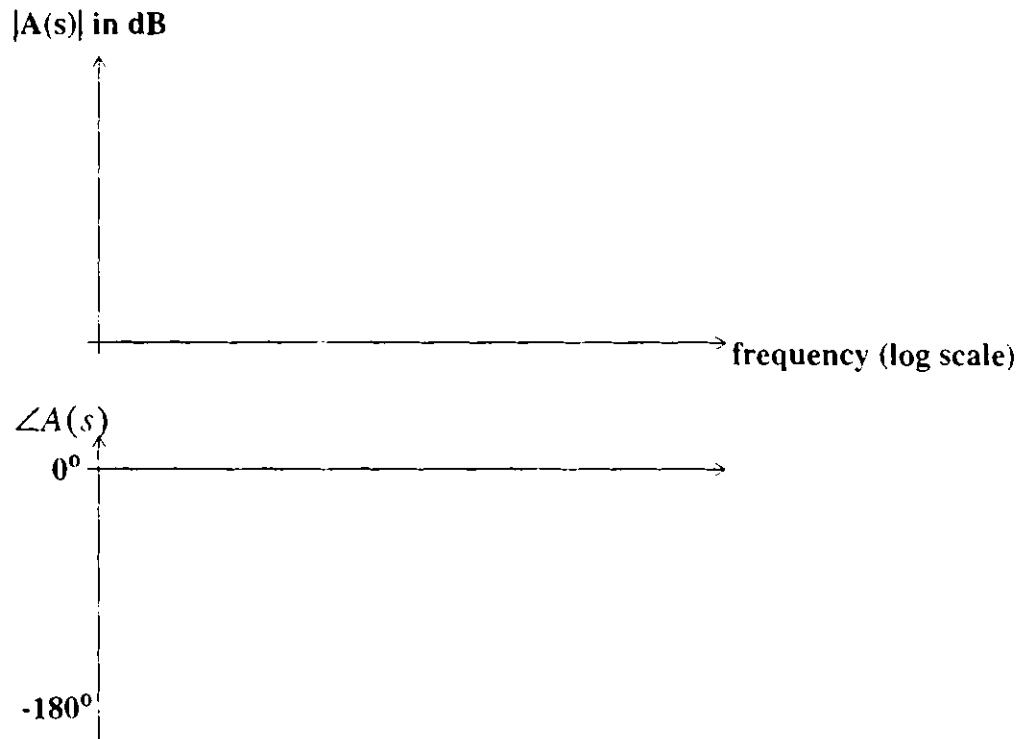
- b) What is the slew rate of the amplifier? Is the op amp limited by its positive or negative slew rate? Assume the device parasitic capacitances are negligible.

Question 3: [10] You are given an op amp IC that has not been compensated to allow for unity-feedback operation. The op amp has the following frequency response

$$A(s) = \frac{A_o}{(1 + s/\omega_{p1})(1 + s/\omega_{p2})}$$

where $A_o = 3.16 \times 10^5$, $\omega_{p1} = 2\pi \times 500\text{Hz}$, $\omega_{p2} = 2\pi \times 15.8\text{MHz}$.

- a) Sketch the Bode plot for the open-loop op amp.



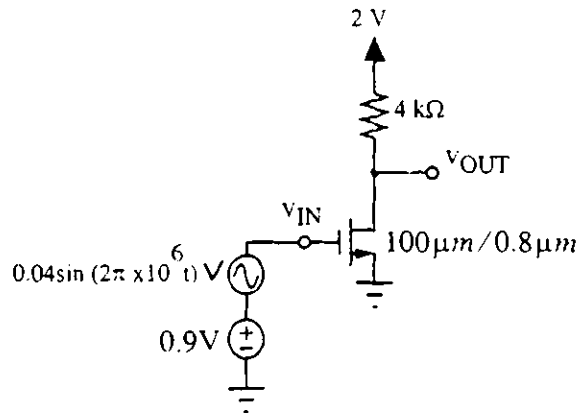
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- b) If we want to ensure a step response with no overshoot, what is the maximum feedback factor, β , that can be used for this op amp in closed-loop configuration? (Hint: no overshoot occurs if the phase margin is greater than 75 degrees)

b) Circle the operating region that each MOSFET is in:

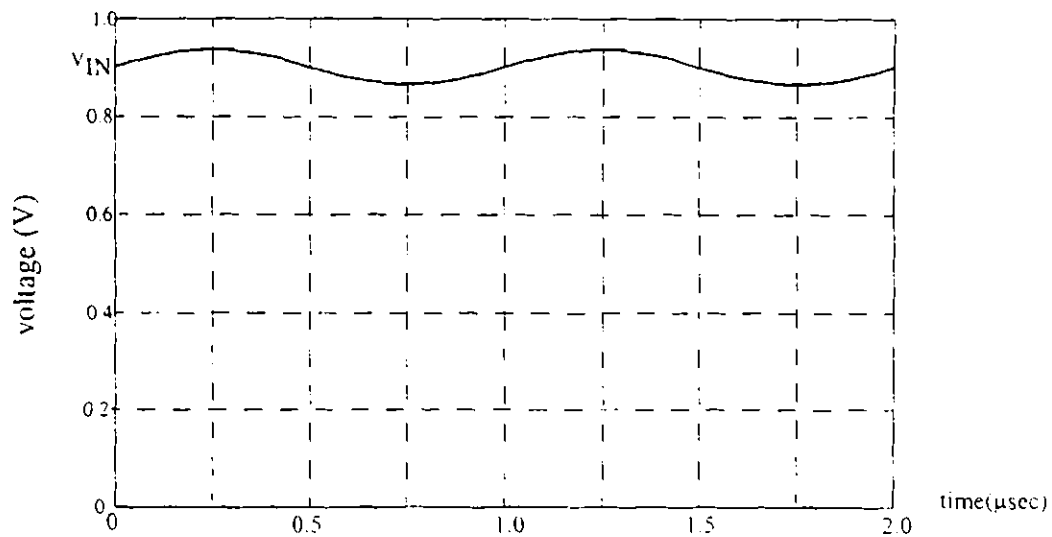
MOSFET	Operating Region	
Q1	Triode	Active
Q2	Triode	Active
Q3	Triode	Active
Q4	Triode	Active
Q5	Triode	Active
Q6	Triode	Active
Q7	Triode	Active
Q8	Triode	Active
Q9	Triode	Active

Question 5: [8] For the following amplifier circuit

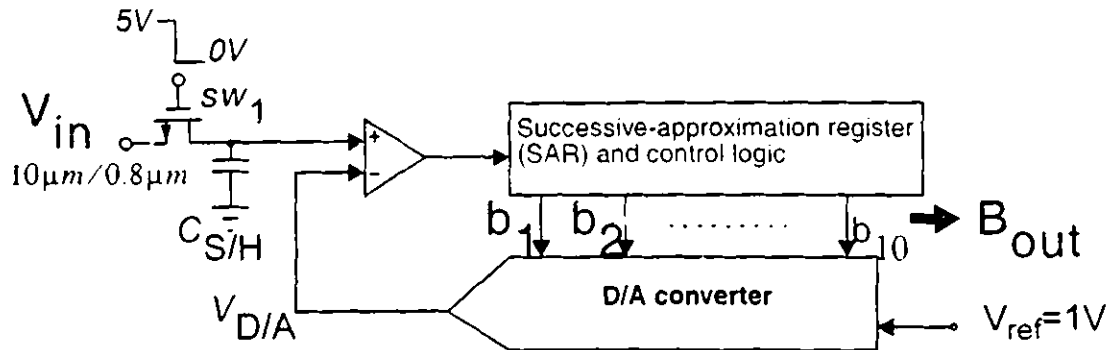


a) Find the small-signal gain. Assume $\lambda = 0$.

b) Given the input waveform, v_{IN} , sketch the approximate output waveform, v_{OUT} , on the same graph. Assume the parasitic capacitances are negligible.



Question 6: [8] The unipolar, 10-bit, successive-approximation (binary-search) A/D converter shown below uses a sample-and-hold circuit at the input. The input range is from 0V to 1V.



- a) What is the maximum allowable voltage error of the sample-and-hold circuit in order to maintain 1/2 LSB accuracy?
- b) Assuming the allowable voltage error due to charge injection and clock feedthrough of the S/H circuit is $\pm 1\text{ mV}$, determine the minimum required size of capacitor $C_{S/H}$. Use the process parameters for the 0.5 μm process found on equation summary sheet. Ignore the body effect on SW_1 , and assume that the portion of channel charge that is transferred to $C_{S/H}$ when SW_1 is opened may vary from 30% to 70%. (Hint: identify the worst-case scenario)

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Question 6 (cont.)

Device Modelling Summary

$q = 1.602 \times 10^{-19} \text{ C}$	$k = 1.38 \times 10^{-23} \text{ J/K}$
$n_i = 1.1 \times 10^{16} \text{ carriers/m}^3 \text{ at } T = 300 \text{ K}$	$\epsilon_0 = 8.854 \times 10^{-12} \text{ F/m}$
$k_B = 1.9$	$K_1 = 11.8$
$\mu_n = 0.25 \text{ m}^2/\text{V s}$	$\mu_p = 0.07 \text{ m}^2/\text{V s}$

Diode Equations

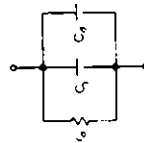
Reverse-Biased Diode (Abrupt Junction)

$C_j = \frac{C_{j0}}{1 - \frac{V_D}{\Phi_0}}$	$Q = 2C_{j0}\Phi_0 \sqrt{1 - \frac{V_D}{\Phi_0}}$
$C_{j0} = \frac{qK_1 \epsilon_0 N_A N_D}{4 \sqrt{\Phi_0} \sqrt{N_A + N_D}}$	$C_{j0} = \sqrt{\frac{qK_1 \epsilon_0 N_D}{2\Phi_0}} \text{ if } N_A \gg N_D$
$\Phi_0 = \frac{kT}{q} \ln \left(\frac{N_A N_D}{n_i^2} \right)$	

Forward-Biased Diode

$I_0 = I_S e^{V_D/V_T}$	$I_S = A_0 q n_i^2 \left(\frac{D_n}{L_n N_A} + \frac{D_p}{L_p N_D} \right)$
$V_T = \frac{kT}{q} = 26 \text{ mV at } 300 \text{ K}$	

Small-Signal Model of Forward-Biased Diode



$V_D = \frac{V_0}{I_0}$	$C_j = C_{j0} + C_D$
$C_D = \tau_D \frac{I_0}{V_0}$	$C_D = 2C_{j0}$
$r_D = \frac{V_0}{I_0}$	$r_D = \frac{V_0}{I_0}$

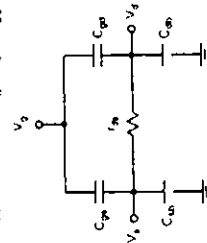
MOS Transistor Equations

The following equations are for n-channel devices—for p-channel devices, put negative signs in front of all voltages. These equations do not account for short-channel effects (i.e., $L < 2\lambda_{\text{eff}}$)

Triode Region ($V_{DS} > V_{DS,sat}$, $V_{GS} \leq V_{th}$)

$I_D = \mu_n C_{ox} \left(\frac{W}{L} \right) (V_{GS} - V_{th}) V_{DS}$	$V_{th} = V_{GS} - V_{th}$
$V_{th} = V_{GS} - V_{th}$	$V_{th} = V_{GS} - V_{th}$
$\Phi_F = \frac{kT}{q} \ln \left(\frac{N_A}{n_i} \right)$	$\Phi_F = \frac{kT}{q} \ln \left(\frac{N_A}{n_i} \right)$
$C_{ox} = \frac{\epsilon_0 \epsilon_{ox}}{t_{ox}}$	

Small-Signal Model in Triode Region (for $V_{GS} \ll V_{th}$)



$g_m = \frac{I_D}{V_{GS} - V_{th}}$	$C_{gs} = C_{gs} + \frac{1}{2} W L C_{ox}$
$C_{gd} = C_{gd} + \frac{1}{2} W L C_{ox}$	$C_{ds} = C_{ds} + \frac{1}{2} W L C_{ox}$

Active (or Pinch-Off) Region ($V_{GS} > V_{th}$, $V_{DS} \geq V_{DS,sat}$)

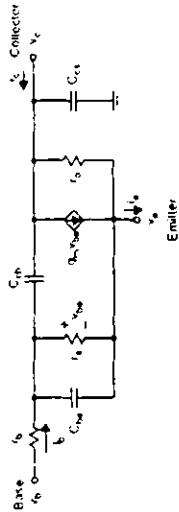
$I_D = \frac{\mu_n C_{ox} W}{2L} (V_{GS} - V_{th})^2 (1 + \lambda(V_{DS} - V_{DS,sat}))$	$V_{th} = V_{GS} - V_{th}$
$\lambda = \frac{1}{L} \sqrt{\frac{q}{\epsilon_0 \epsilon_{ox}}} \Phi_F$	$V_{th} = V_{GS} - V_{th}$
$V_{th} = V_{GS} - V_{th}$	$V_{th} = V_{GS} - V_{th}$

Bipolar-Junction Transistors

Active Transistor

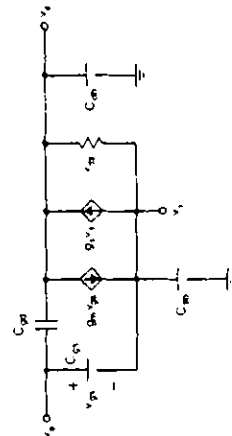
$I_C = I_{CS} e^{V_{BE}/V_T}$	$V_T = \frac{kT}{q} \approx 26 \text{ mV at } 100^\circ \text{K}$
For more accuracy, $I_C = I_{CS} e^{V_{BE}/V_T} \left(1 + \frac{V_{CE}}{V_A}\right)$	
$I_{CS} = \frac{A_S q D_n n_i^2}{W N_A}$	$I_C = I_C$
$I_E = \left(1 + \frac{1}{\beta}\right) I_C = \frac{1}{\alpha} I_C = (\beta + 1) I_B$	$\beta = \frac{I_C}{I_B} = \frac{D_n N_D (1 - \frac{N_D}{N_A})}{D_p N_A (1 - \frac{N_D}{N_A})}$
$\alpha = \frac{\beta}{1 + \beta}$	

Small-Signal Model of an Active BJT



$g_m = \frac{I_C}{V_T}$	$r_o = \frac{V_T}{I_C} = \frac{\beta}{g_m}$
$r_{\pi} = \frac{\beta}{g_m}$	$r_o = \frac{V_A}{I_C}$
$g_{m,0} = \frac{V_A}{V_T}$	$C_{\pi} = C_{\pi} + C_{\mu} = \frac{A_S q D_n n_i^2}{W N_A} \left(1 + \frac{V_{CE}}{V_A}\right)^{-1}$
$C_{\pi} = C_{\pi} + C_{\mu}$	$C_{\mu} = \frac{A_S q D_p n_i^2}{W N_A} \left(1 + \frac{V_{CE}}{V_A}\right)^{-1}$
$C_{CE} = \frac{A_S q D_n n_i^2}{W N_A} \left(1 + \frac{V_{CE}}{V_A}\right)^{-1}$	

Small-Signal Model (Active Region)



$g_m = \mu_n C_{ox} \left(\frac{W}{L}\right) V_{ov}$	$g_m = \mu_n C_{ox} \left(\frac{W}{L}\right) V_{ov}$
$r_{\pi} = \frac{1}{g_m}$	$r_{\pi} = \frac{1}{g_m}$
$r_{ds} = \frac{1}{g_{ds}}$	$r_{ds} = \frac{1}{g_{ds}}$
$\lambda = \frac{1}{2V_{A0}}$	$\lambda = \frac{1}{2V_{A0}}$
$C_{gs} = \frac{1}{2} W L C_{ox} + W L C_{gs}$	$C_{gs} = \frac{1}{2} W L C_{ox} + W L C_{gs}$
$C_{gd} = (A_{gs} + W L C_{gs}) + P_{gs}$	$C_{gd} = (A_{gs} + W L C_{gs}) + P_{gs}$
$C_{ds} = A_{ds} C_{ds} + P_{ds}$	$C_{ds} = A_{ds} C_{ds} + P_{ds}$

Typical Values for a 0.5-μm Process

$V_{DD} = 0.5 \text{ V}$	$V_{GS} = 0.4 \text{ V}$
$\mu_n C_{ox} = 170 \text{ } \mu\text{A/V}^2$	$\mu_p C_{ox} = 40 \text{ } \mu\text{A/V}^2$
$C_{gs} = 1.4 \times 10^{-1} \text{ pF/}\mu\text{m}^2$	$C_{gd} = 5.4 \times 10^{-1} \text{ pF/}\mu\text{m}^2$
$C_{ds} = 1.4 \times 10^{-1} \text{ pF/}\mu\text{m}^2$	$C_{gs,eq} = 1.7 \times 10^{-1} \text{ pF/}\mu\text{m}^2$
$\theta = 0.42 \text{ V}$	$\theta = 0.42 \text{ V}$
$\gamma = 0.6 \text{ V}^{1/2}$	$\gamma = 0.6 \text{ V}^{1/2}$
$N_A = 1.1 \times 10^{17} \text{ atoms/cm}^3$	